

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/053,304	VELLANTE ET AL.
	<b>Examiner</b> Fadey S. Jabr	<b>Art Unit</b> 3639

**SEARCHED**

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East Search, see attached	12/17/2005	FSJ
EIC Search, see attached	12/17/2005	FSJ
EIC Plus Search, see attached	12/17/2005	FSJ

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner